

SEMiX252GB126HDs



SEMiX® 2s

Trench IGBT Modules

SEMiX252GB126HDs

Features

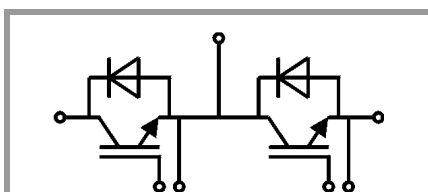
- Homogeneous Si
- Trench = Trenchgate technology
- $V_{CE(sat)}$ with positive temperature coefficient
- High short circuit capability
- UL recognised file no. E63532

Typical Applications*

- AC inverter drives
- UPS
- Electronic Welding

Remarks

- Case temperatur limited to $T_C=125^\circ\text{C}$ max.
- Not for new design



GB

Absolute Maximum Ratings				
Symbol	Conditions		Values	Unit
IGBT				
V _{CES}	T _j = 25 °C		1200	V
I _C	T _j = 150 °C	T _c = 25 °C	242	A
		T _c = 80 °C	170	A
I _{Cnom}			150	A
I _{CRM}	I _{CRM} = 2xI _{Cnom}		300	A
V _{GES}			-20 ... 20	V
t _{psc}	V _{CC} = 600 V V _{GE} ≤ 20 V V _{CES} ≤ 1200 V	T _j = 125 °C	10	μs
T _j			-40 ... 150	°C
Inverse diode				
I _F	T _j = 150 °C	T _c = 25 °C	228	A
		T _c = 80 °C	158	A
I _{Fnom}			150	A
I _{FRM}	I _{FRM} = 2xI _{Fnom}		300	A
I _{FSM}	t _p = 10 ms, sin 180°, T _j = 25 °C		1000	A
T _j			-40 ... 150	°C
Module				
I _{t(RMS)}	T _{terminal} = 80 °C		600	A
T _{stg}			-40 ... 125	°C
V _{isol}	AC sinus 50Hz, t = 1 min		4000	V

Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
IGBT						
V _{CE(sat)}	I _C = 150 A	T _j = 25 °C		1.7	2.1	V
	V _{GE} = 15 V chipelevel	T _j = 125 °C		2.0	2.45	V
V _{CE0}		T _j = 25 °C		1	1.2	V
		T _j = 125 °C		0.9	1.1	V
r _{CE}	V _{GE} = 15 V	T _j = 25 °C		4.7	6.0	mΩ
		T _j = 125 °C		7.3	9.0	mΩ
V _{GE(th)}	V _{GE} =V _{CE} , I _C = 6 mA		5	5.8	6.5	V
I _{CES}	V _{GE} = 0 V	T _j = 25 °C		0.1	0.3	mA
	V _{CE} = 1200 V	T _j = 125 °C				mA
C _{ies}	V _{CE} = 25 V V _{GE} = 0 V	f = 1 MHz		10.7		nF
C _{oes}		f = 1 MHz		0.56		nF
C _{res}		f = 1 MHz		0.48		nF
Q _G	V _{GE} = - 8 V...+ 15 V			1200		nC
R _{Gint}	T _j = 25 °C			5.00		Ω
t _{d(on)}	V _{CC} = 600 V	T _j = 125 °C		300		ns
t _r	I _C = 150 A	T _j = 125 °C		45		ns
E _{on}	V _{GE} = ±15 V	T _j = 125 °C		20		mJ
t _{d(off)}	R _{G on} = 3 Ω	T _j = 125 °C		570		ns
t _f	R _{G off} = 3 Ω	T _j = 125 °C		110		ns
E _{off}		T _j = 125 °C		21		mJ
R _{th(j-c)}	per IGBT				0.15	K/W

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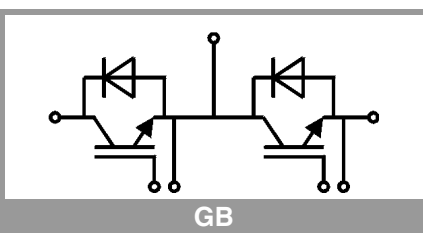
Typical Applications*

- AC inverter drives
- UPS
- Electronic Welding

Remarks

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- Not for new design

Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
Inverse diode						
V _F = V _{EC}	I _F = 150 A	T _j = 25 °C		1.6	1.80	V
	V _{GE} = 0 V chip	T _j = 125 °C		1.6	1.8	V
V _{F0}		T _j = 25 °C	0.9	1	1.1	V
		T _j = 125 °C	0.7	0.8	0.9	V
r _F		T _j = 25 °C	3.3	4.0	4.7	mΩ
		T _j = 125 °C	4.7	5.3	6.0	mΩ
I _{RRM}	I _F = 150 A	T _j = 125 °C		260		A
Q _{rr}	di/dt _{off} = 4600 A/μs	T _j = 125 °C		43		μC
E _{rr}	V _{GE} = -15 V	T _j = 125 °C		18		mJ
	V _{CC} = 600 V					
R _{th(j-c)}	per diode				0.24	K/W
Module						
L _{CE}				18		nH
R _{CC'+EE'}	res., terminal-chip	T _C = 25 °C		0.7		mΩ
		T _C = 125 °C		1		mΩ
R _{th(c-s)}	per module			0.045		K/W
M _s	to heat sink (M5)		3		5	Nm
M _t		to terminals (M6)	2.5		5	Nm
						Nm
w					250	g
Temperatur Sensor						
R ₁₀₀	T _c =100°C (R ₂₅ =5 kΩ)			493 ± 5%		Ω
B _{100/125}	R(Τ)=R ₁₀₀ exp[B _{100/125} (1/T-1/T ₁₀₀)]; T[K];			3550 ±2%		K



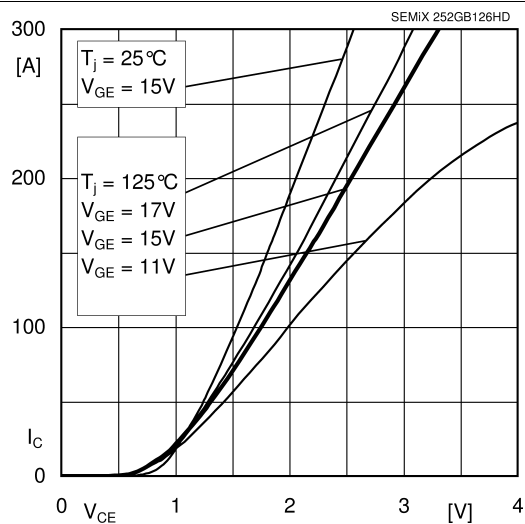


Fig. 1: Typ. output characteristic, inclusive $R_{CC} + E_{E'}$

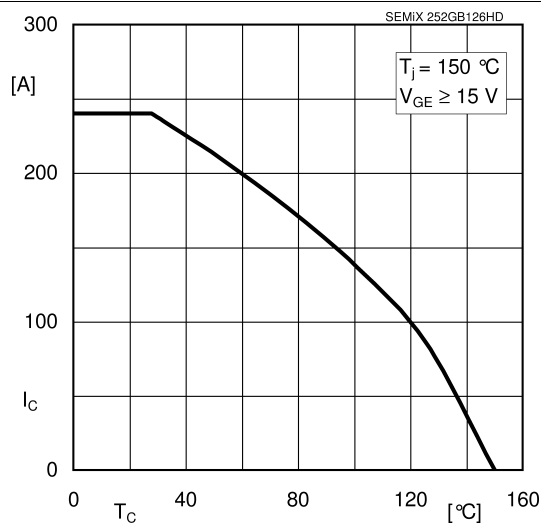


Fig. 2: Rated current vs. temperature $I_C = f(T_C)$

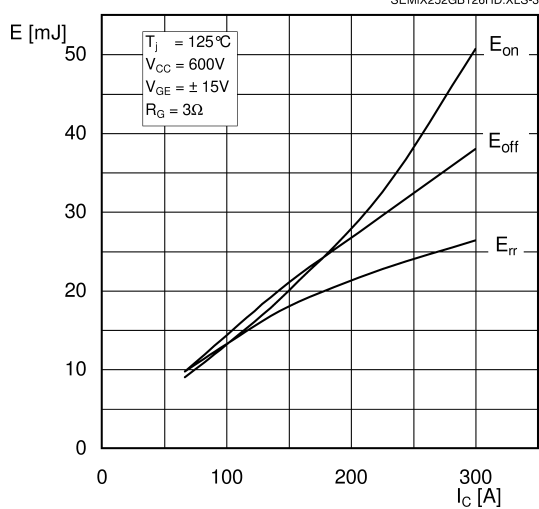


Fig. 3: Typ. turn-on /-off energy = $f(I_C)$

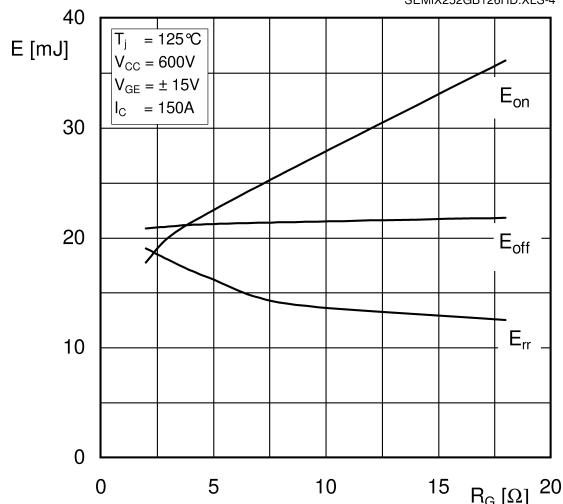


Fig. 4: Typ. turn-on /-off energy = $f(R_G)$

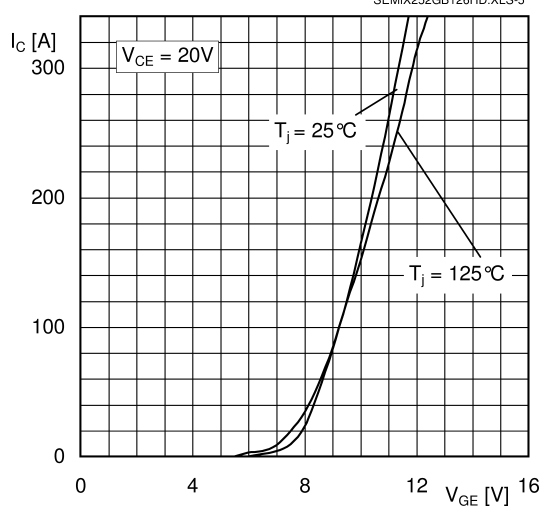


Fig. 5: Typ. transfer characteristic

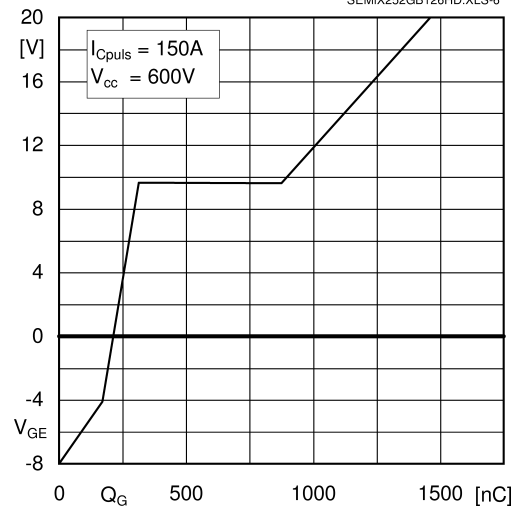


Fig. 6: Typ. gate charge characteristic

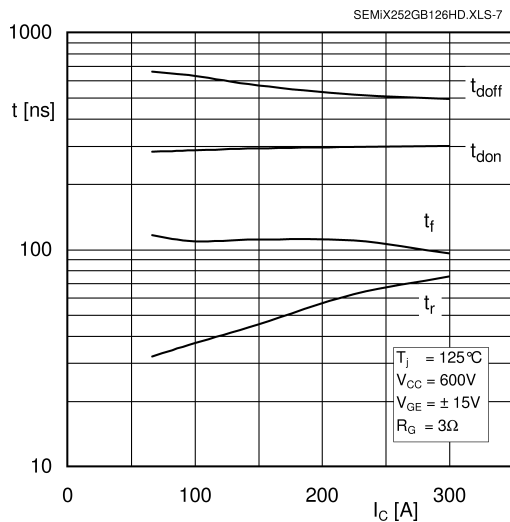


Fig. 7: Typ. switching times vs. I_C

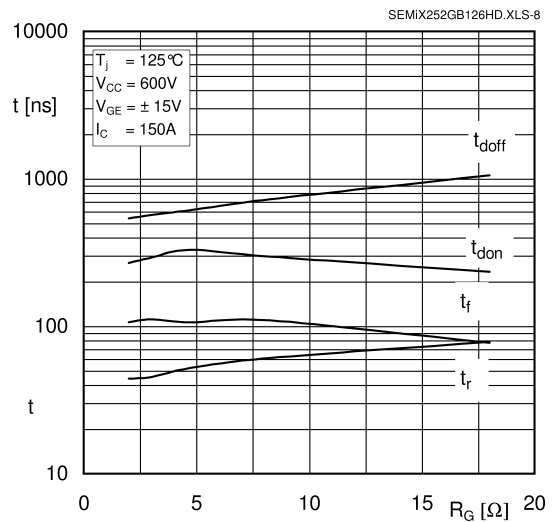


Fig. 8: Typ. switching times vs. gate resistor R_G

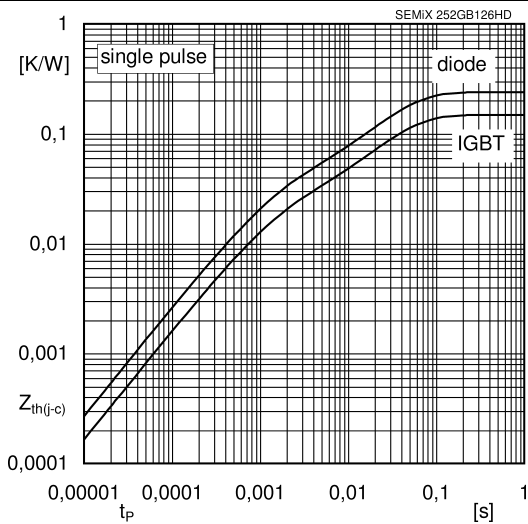


Fig. 9: Typ. transient thermal impedance

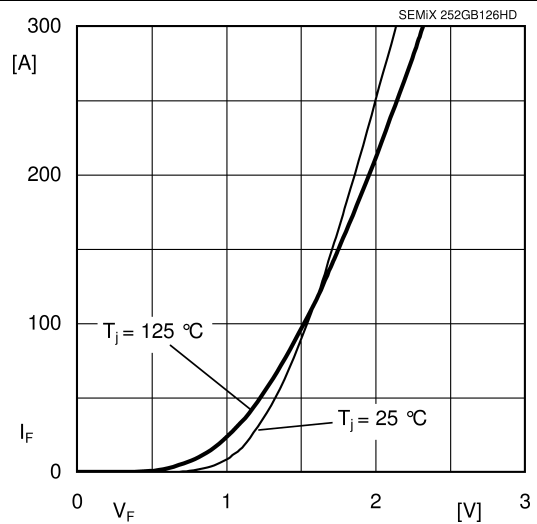


Fig. 10: Typ. CAL diode forward charact., incl. $R_{CC'+EE'}$

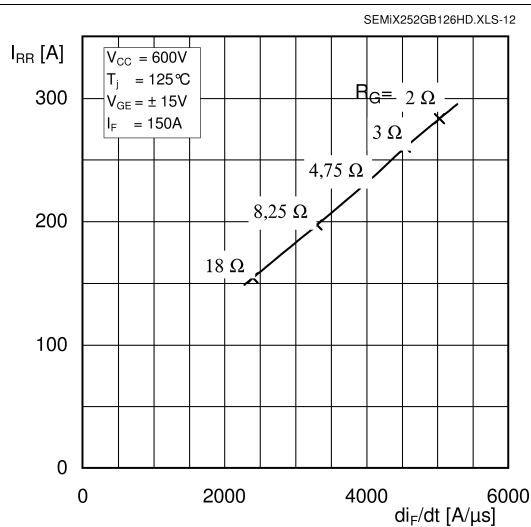


Fig. 11: Typ. CAL diode peak reverse recovery current

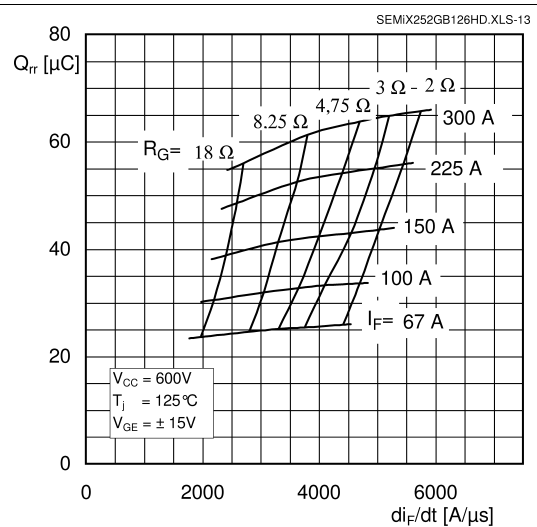
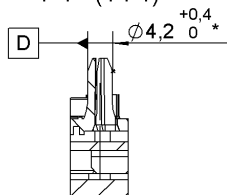


Fig. 12: Typ. CAL diode recovery charge

SEMiX252GB126HDs

Case: SEMiX 2s

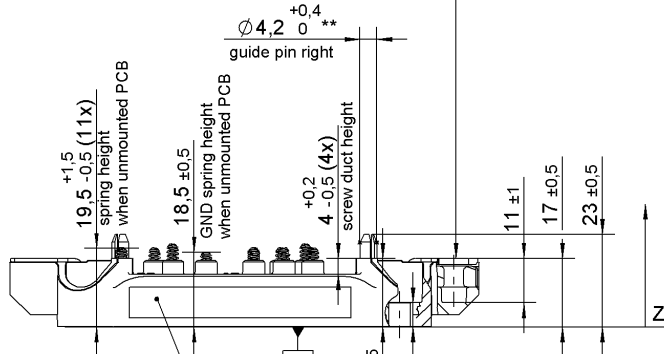
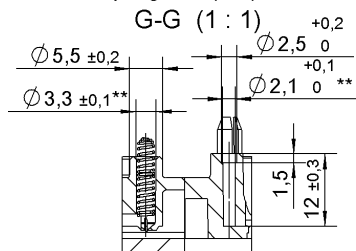
guide pin left
F-F (1 : 1)



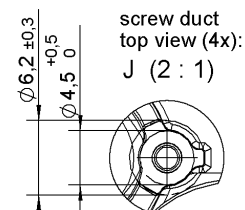
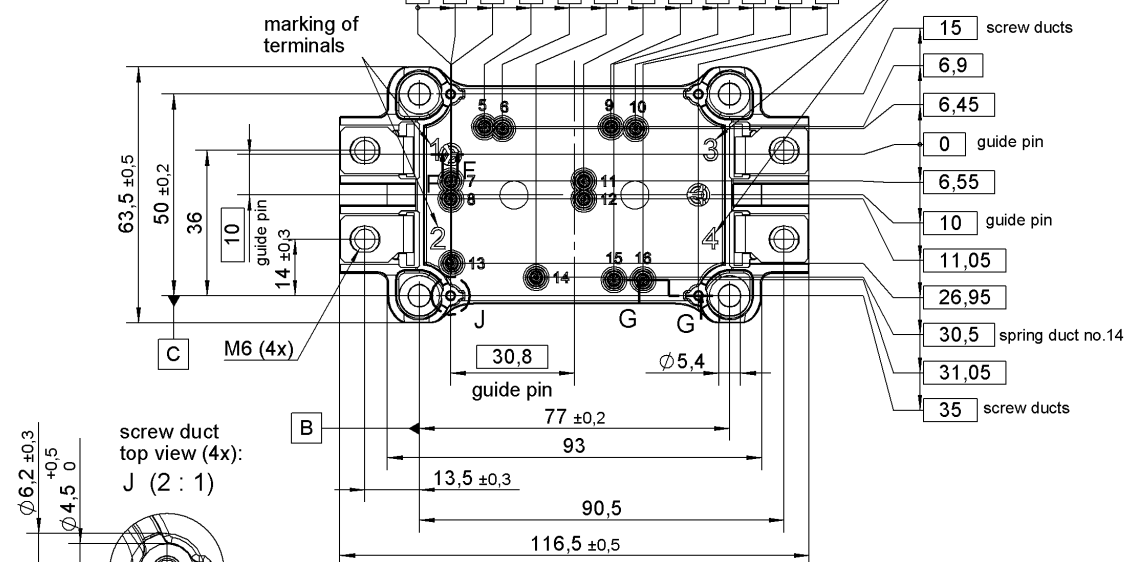
	0,3	connector 1-2 / 3-4
	0,2	each connector A

general tolerance:
ISO 2768-m
ISO 8015

screw duct (4x)
spring duct (12x):
G-G (1 : 1)



All measures in Z-direction
valid when mounted to heat sink



*guide pin left with

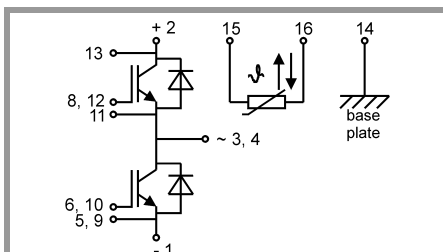
	$\varnothing$ 0,25	A	B	C
	$\varnothing$ 0,5	A	D	C

Rules for the contact PCB:

- holes guidepins = $\varnothing 4 \pm 0,1$ / position tolerance $\pm 0,1$
- holes for screws = $\varnothing 3,3 \pm 0,1$ / position tolerance $\pm 0,1$
- spring contact pad = $\varnothing 3,6 \pm 0,1$ / position tolerance $\pm 0,1$

**screw ducts / spring ducts / guide pin right with

SEMiX 2s



spring configuration

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX

* The specifications of our components may not be considered as an assurance of component characteristics. Components have to be tested for the respective application. Adjustments may be necessary. The use of SEMIKRON products in life support appliances and systems is subject to prior specification and written approval by SEMIKRON. We therefore strongly recommend prior consultation of our staff.